

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/764,644	CHEN ET AL.
	<b>Examiner</b> Thuy Pardo	<b>Art Unit</b> 2165

SEARCHED			
Class	Subclass	Date	Examiner
707	3	7/1/05	151
	5		
	10		
	101		
	102		
	103		
↓	104		
705	10		
✓	104		
345	236		
709	206	↓	↓

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
707	8 5	7/1/05	155
	10		
	101		
	102		
	103		
705	104		
	10		
✓	14		
345	236		
709	206		